

Supporting Information

Broadband photomultiplication organic photodetectors

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Experimental Section

Device fabrication: The OPDs were fabricated on the patterned indium tin oxide (ITO) coated glass substrates with a sheet resistance of 15 Ω/cm^2 . The ITO glass substrates were pre-cleaned by sequential sonication in detergent, deionized water and ethanol. All the cleaned ITO glass substrates were blow-dried by high-purity nitrogen gas and then treated with oxygen plasma for 1 minute to improve the work function and clearance. Subsequently, the poly(3,4-ethylenedioxythiophene):poly(styrene sulfonate) (PEDOT:PSS, Clevis PVP AI.4083, purchased from H.C. Starck Co., Ltd.) solution was spin-coated onto the cleaned ITO glass substrates at 5000 rounds per minute (RPM) for 30 s, and then annealed at 150 °C for 15 minutes in atmospheric air. After annealing treatment, all the ITO glass substrates coated with PEDOT:PSS layer were transferred into a high-purity nitrogen-filled glovebox to fabricate active layers. Polymer poly[(2,6-(4,8-bis(5-(2-ethylhexyl)thiophen-2-yl)-benzo [1,2-b:4,5-b'] dithiophene))-alt-(5,5-(1',3'-di-2-thienyl-5',7'-bis(2-ethylhexyl)benzo [1',2'-c:4',5'-c'] dithiophene-4,8-dione))] (PBDB-T) and 2,2'-((2Z,2'Z)-(((4,4,9,9-tetrakis(4-hexylphenyl)-4,9-dihydro-sindaceno[1,2-b:5,6-b']dithiophene-2,7-diyl)bis(4-((2-ethylhexyl)oxy)thiophene-5,2-diyl))bis(methanylylidene))bis(5,6-difluoro-3-oxo-2,3-dihydro-1H-indene-2,1-diylidene)) dimalononitrile (IEICO-4F) (purchased from Solarmer Materials Inc.) were dissolved in chlorobenzene (CB) solvent to prepare 10 mg/mL solutions, respectively. Then, the IEICO-4F and PBDB-T solutions were blended with the weight ratios of 1:1 and 3:100, respectively. For the PD-OPDs and single-layered PM-OPDs, the mixed solutions of IEICO-4F:PBDB-T with the weight ratios of 1:1 or 3:100 were individually spin-coated onto the top of PEDOT:PSS layer at 400 RPM for 30 s and then annealed at 150 °C for 10 minutes to prepare active layers. For double-layered PM-OPDs, firstly, the mixed solution of the IEICO-4F:PBDB-T with weight ratio of 1:1 was spin-coated onto the top of PEDOT:PSS layer at 400 RPM for 30 s

and then annealed at 150 °C for 10 minutes to prepare photon harvesting layer; secondly, the mixed solution of the IEICO-4F:PBDB-T with weight ratio of 3:100 were dynamic spin-coated onto the top of IEICO-4F:PBDB-T (1:1, wt/wt) layer at 2000 RPM for 30 s to prepare PM layer. The spin-coating method for preparing organic semiconducting thin films has been commonly reported in many fields, such as organic light emitting diodes, organic solar cells, organic transistors, and organic photodetectors.[1-4] The thickness of active layers were measured by using an AMBIOS Technology XP-2 stylus profilometer. The Al electrode (100 nm) was deposited onto the active layer by thermal evaporation in a high vacuum (10^{-4} Pa) chamber and the thickness was monitored with a quartz crystal microbalance. The active area of the prepared OPDs is approximate 3.8 mm², which is defined by the vertical overlapping area between Al electrode and ITO electrode.

Films and Devices Testing: The current density versus voltage (J - V) curves of the OPDs were measured by using a Keithley 2400 source meter. The used monochromatic light was provided by a 150 W xenon lamp coupled with a monochromator. The light intensity spectrum of monochromatic light was recorded by using a Thorlabs S120VC power meter. The ultraviolet-visible (UV-Vis) absorption spectra were recorded by a SHIMADZU UV-3101 PC spectrophotometer. The noise current was obtained from the fast Fourier transform (FFT) of the dark current versus time curves.

Calculation of performance parameters: The external quantum efficiency (EQE) of OPDs can be calculated according to the ratio of the number of holes collected by electrode to the number of incident photons. Responsivity (R) is defined as the ratio of the photo-induced current density to the incident light intensity. The EQE and R can be calculated according to Equation (S1) and (S2):

$$EQE = \frac{(J_L - J_D)/e}{I_{in}/h\nu} \quad (S1)$$

$$R = \frac{J_L - J_D}{I_{in}} = \frac{EQE \cdot e}{h\nu} \quad (S2)$$

in which J_L is the current density under light illumination, J_D is the current density in dark condition, e is elementary electron charge (1.6×10^{-19} C), I_{in} is incident light intensity, h is the Plank constant, ν is photon frequency.

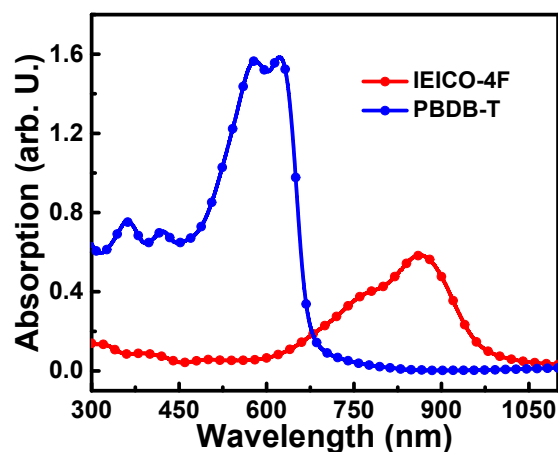


Figure S1 The absorption spectra of neat IEICO-4F and PBDB-T films.

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